Application No. 10/613,040 Docket No.: 6796-000003/US/DVA

Page 3

## AMENDMENTS TO THE CLAIMS

The following is a complete listing of claims with a status identifier in parenthesis.

## Listing of the Claims

1-22 (Canceled)

23. (Previously Presented) A method for heating a sample, said method comprising:

providing a heating apparatus and inserting the sample in an applicator;

generating electromagnetic radiation at a first output power level; and

rotating a deflector for adjusting a coupling factor between a waveguide and a

resonant cavity.

24. (Previously Presented) The method according to claim 23, wherein the sample has a first

temperature T<sub>1</sub>, the method further comprising:

heating the sample to obtain a second temperature  $T_2$ , wherein  $T_2 > T_1$ ; and

rotating the deflector to adjust the coupling factor between the waveguide and the

resonant cavity in response to a variation in a dielectric properties  $\varepsilon_{\text{sample}}$  of the sample.

25. (Currently Amended) The method according to claim 23, wherein rotating the

deflector further comprises:

performing at least once one of the following:

- positioning the deflector in a first position and measuring a first power of electromagnetic

radiation reflected from a waveguide the applicator, the reflected radiation corresponding

to said first position of the deflector,

Application No. 10/613,040 Docket No.: 6796-000003/US/DVA

Page 4

rotating the deflector to a second position that is different from the first position and
measuring a second power of electromagnetic radiation reflected from the waveguide

applicator, the reflected radiation corresponding to said second position of the deflector,

and

determining a preferred position of the deflector based on the amount of power reflected

from the waveguide applicator in at least the first and second positions.

26. (Previously Presented) The method according to claim 25, further comprising:

providing a first storing means;

storing information relating to the first position in the storing means and storing a

measured first power in relation thereto; and

. storing information relating to the second position in the storing means and storing a

measured second power in relation thereto.

27. (Previously Presented) The method according to claim 26, wherein sdetermining the

preferred position of the deflector further comprises processing the stored first and second

measured powers for determining the preferred position of the deflector corresponding to a

local or an absolute minimum in the measured power or to a predetermined ratio of the

measured power to the first output power level.

28. (Previously Presented) The method according to claim 25, further comprising positioning

the deflector in a preferred position.

29. (Previously Presented) The method according to claim 25, further comprising positioning

Application No. 10/613,040 Docket No.: 6796-000003/US/DVA

Page 5

the deflector in a preferred position and generating electromagnetic radiation at a second

output power level which is larger than the first output power level.

30. (Previously Presented) The method according to claim 26, further comprising

determining a relative permittivity measurement of the sample by comparing the stored

measured powers with corresponding stored measured powers from a different sample.

31. (Previously Presented) The method according to claim 26, further comprising

determining an indication of a chemical composition of the sample by comparing the stored

measured powers with corresponding stored measured powers from a sample of known

chemical composition.

32. (Previously Presented) The method according to claim 31, wherein the sample comprises

at least one reactant for performing a chemical reaction.

33. (Currently Amended) The method according to claim 31 32, further comprising:

performing a chemical reaction with the at least one reactant; and

determining a degree of reaction for the chemical reaction using an indication of

chemical composition of the sample.